

<b>Notice of References Cited</b>	Application/Control No. 10/714,825	Applicant(s)/Patent Under Reexamination DECONDE ET AL.	
	Examiner Paul D. Kim	Art Unit 3729	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,010,233	04-1991	Henschen et al.	219/209
*	C	US-4,873,476	10-1989	Kurakake et al.	318/568.22
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	K	US-			
	L	US-			
	M	US-			

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	N	DE 19934054 C1	01-2001	Germany	AYDIN, OEMER	H05K 03/34
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**NON-PATENT DOCUMENTS**

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	U	"A simple fingerprint sensor based on ridge conductivity"; Olavarrieta Fritsche, G.; Nakano Miyatake, M.; Design of Mixed-Mode Integrated Circuits and Applications on 26-28 July 1999; Pages:207 - 209.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.